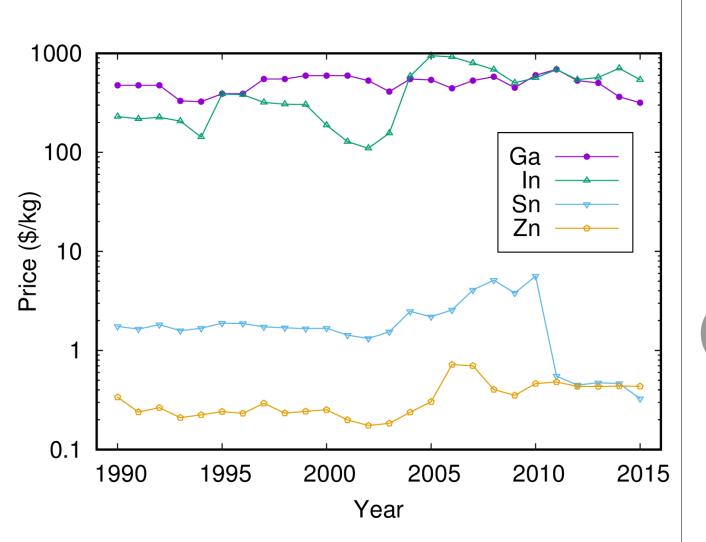
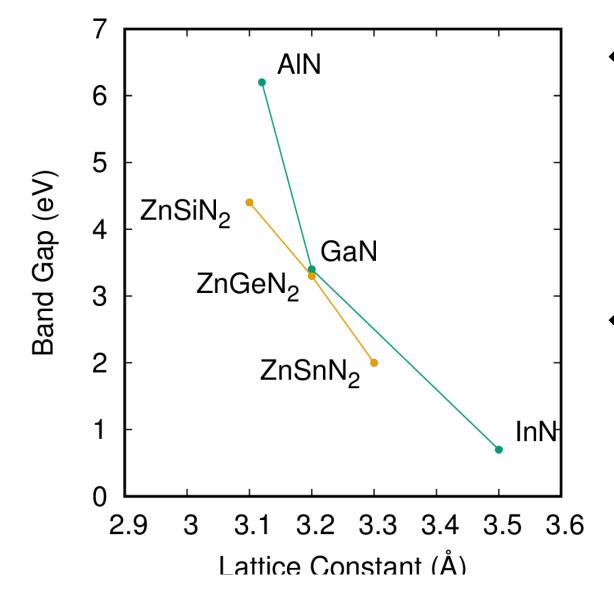
The Problem

- Currently most optoelectronic devices contain materials based on indium or gallium
- In and Ga are relatively expensive metals with currently no recycling infrastructure



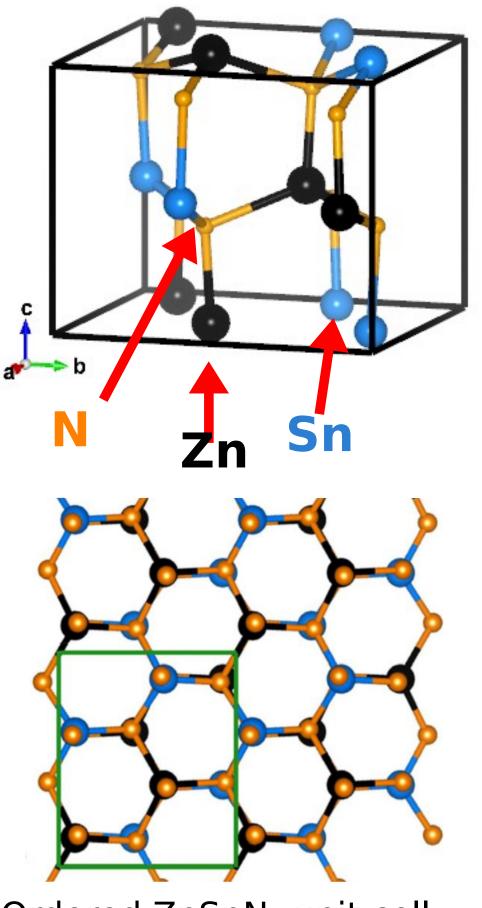
- The family of Zn-IV-N₂ compounds could be viable alternatives for optoelectronic devices
- j 100 **E 80** <u>کل</u> 60 40 20 SU Metal
- Very little is known about the synthesis and properties of these compounds, however
- Both Zn and Sn are eco-friendly metals since reclamation sources account for a large portion of their annual production

Band Gaps and Cation Disorder



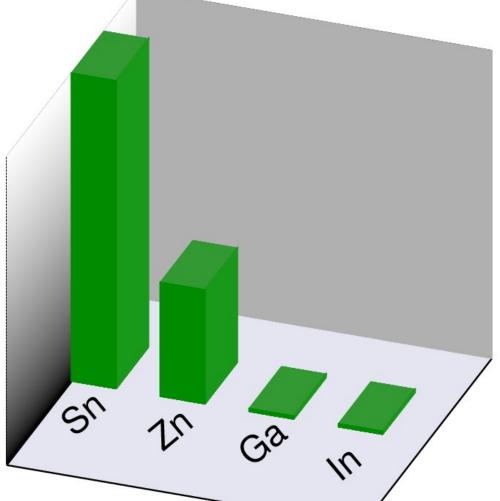
- Randomizing the placement of Zn and Sn (the cations) in the structure causes the lattice to become hexagonal and the band gap to decrease to 1.0 eV
- The optimal band gap for a solar cell is 1.5 eV – halfway between the two extremes
- The goal of this research project is to test this set of order/disorder based band gap predictions for ZnSnN2, and determine to what extent it can be controlled using a commercially important crystal growth technique

- The band gap is a fundamental property of semiconductors; it arises from the periodic arrangement of atoms
- ZnSnN₂ is predicted to have an orthorhombic lattice structure with a band gap of 2.0 eV – suitable for red LEDs



Ordered ZnSnN₂ unit cell (top) and lattice (bottom)





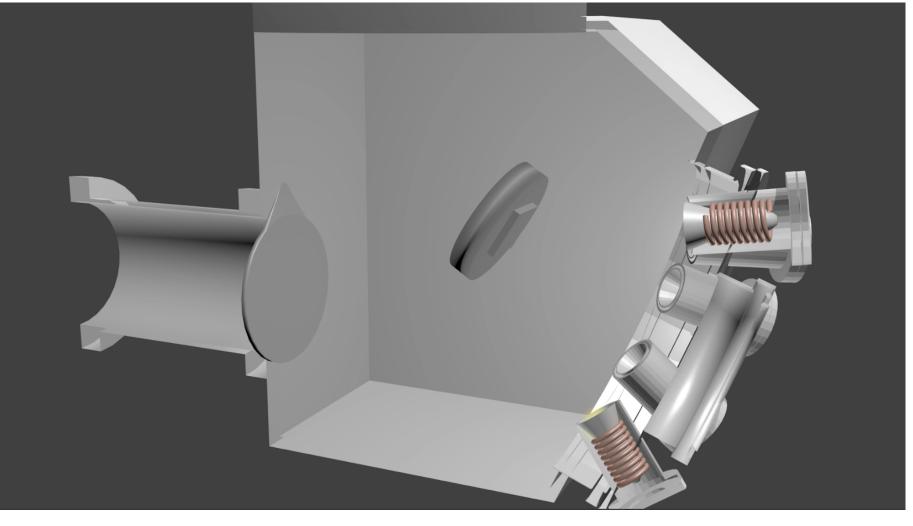
Exploiting Disorder in Novel Semiconductors for Optoelectronic Devices

R. Makin¹, N. Feldberg¹, S.M. Durbin¹, N.Senabulya², J. Mathis², R. Clarke², T. D. Veal³

¹Western Michigan University ²Univserity of Michigan ³University of Liverpool

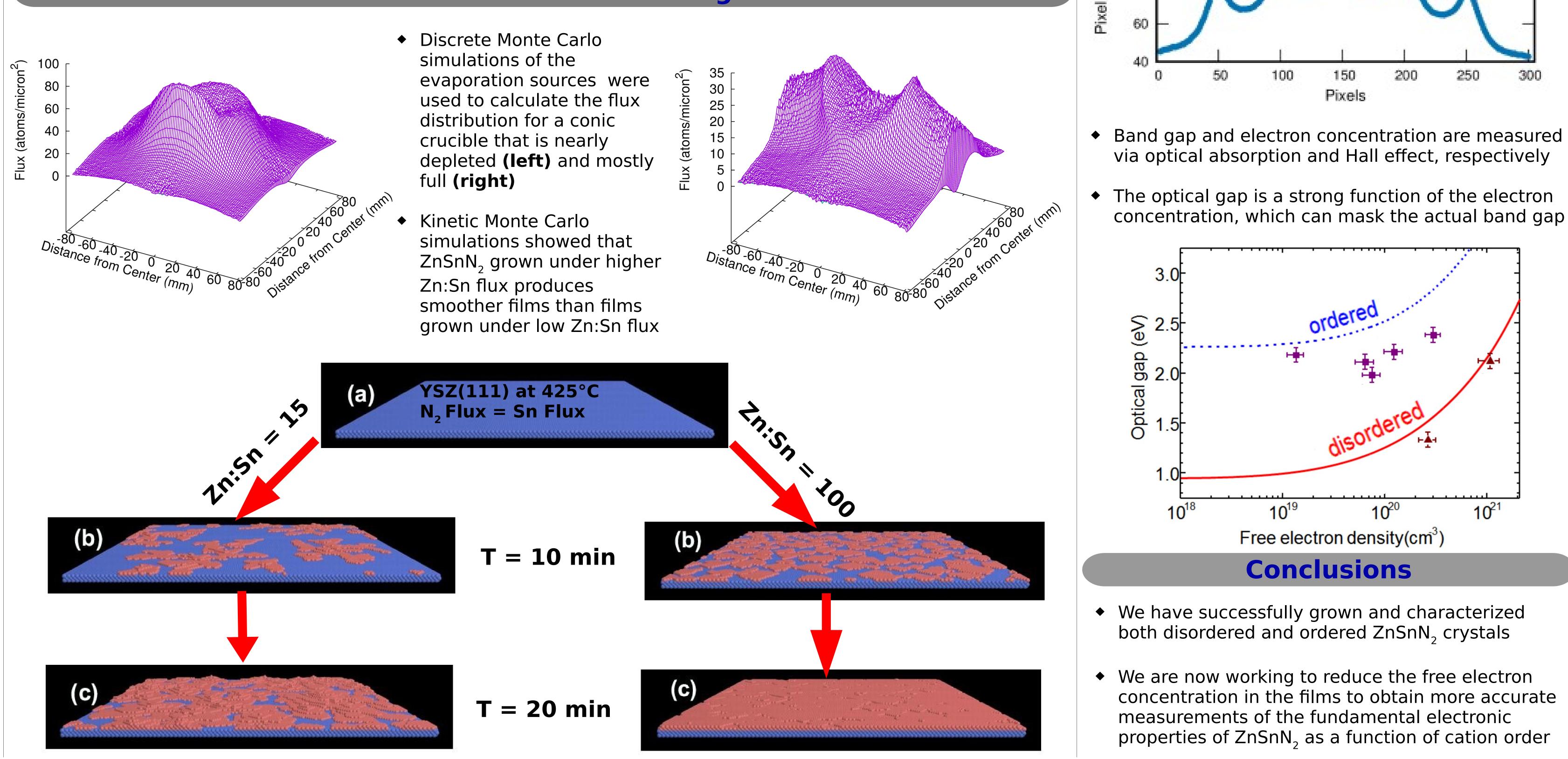
Growing ZnSnN, via Plasma Assisted Molecular Beam Epitaxy (PAMBE)

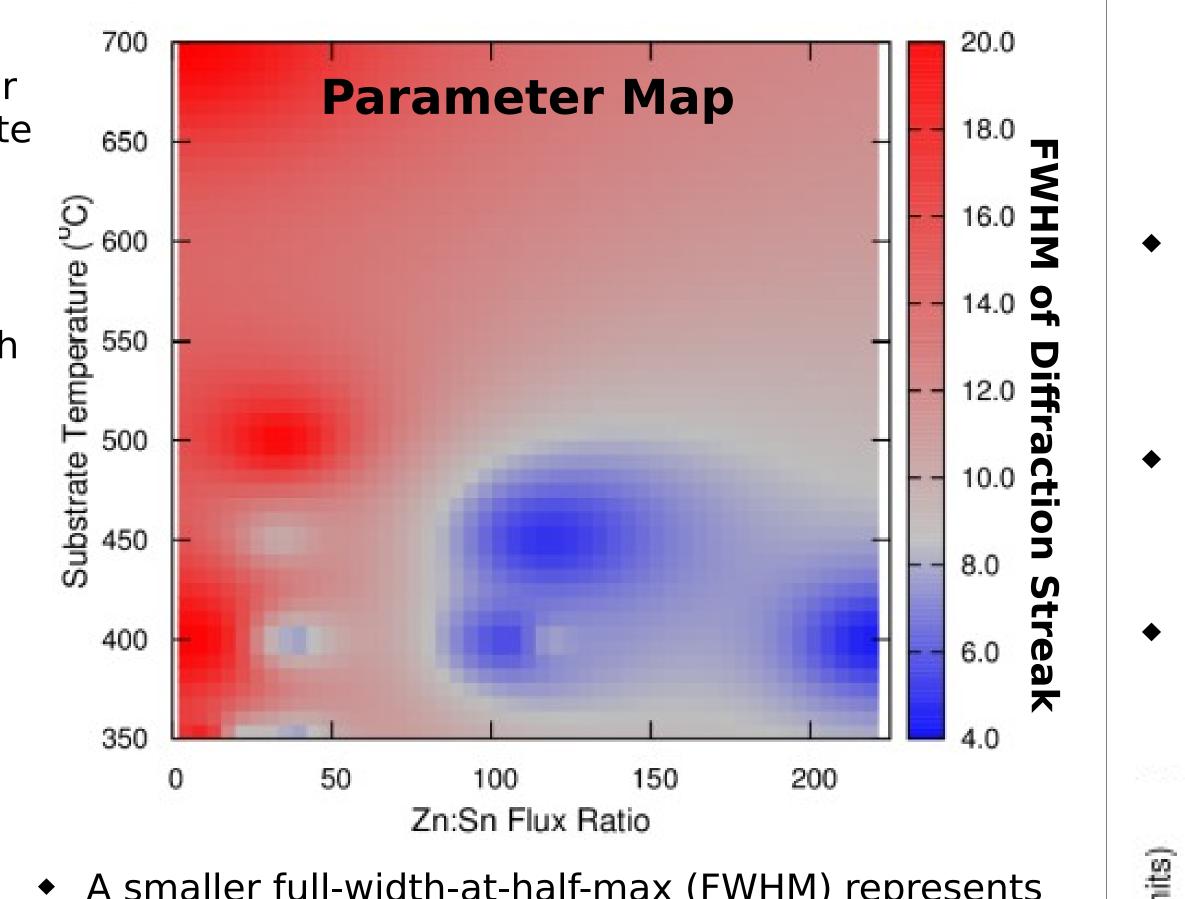
- PAMBE is an ultra-high vacuum thermal vapor deposition technique. High purity Zn and Sn are heated to create vapor beams, which then condense and crystallize on the substrate
- Active Nitrogen is supplied using a radio-frequency inductively coupled plasma source
- The ZnSnN, growth parameter space has been explored with a series of films to optimize crystal quality and to obtain ordered and disordered ZnSnN₂



Schematic of PAMBE System

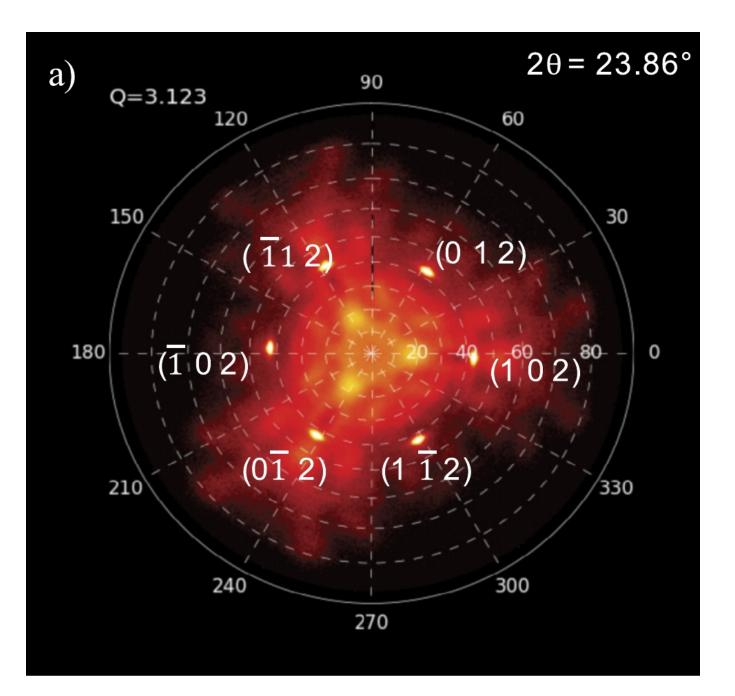
Monte Carlo Simulations: Modeling Growth





 A smaller full-width-at-half-max (FWHM) represents a higher quality crystal, while a larger FWHM represent a lower quality crystal

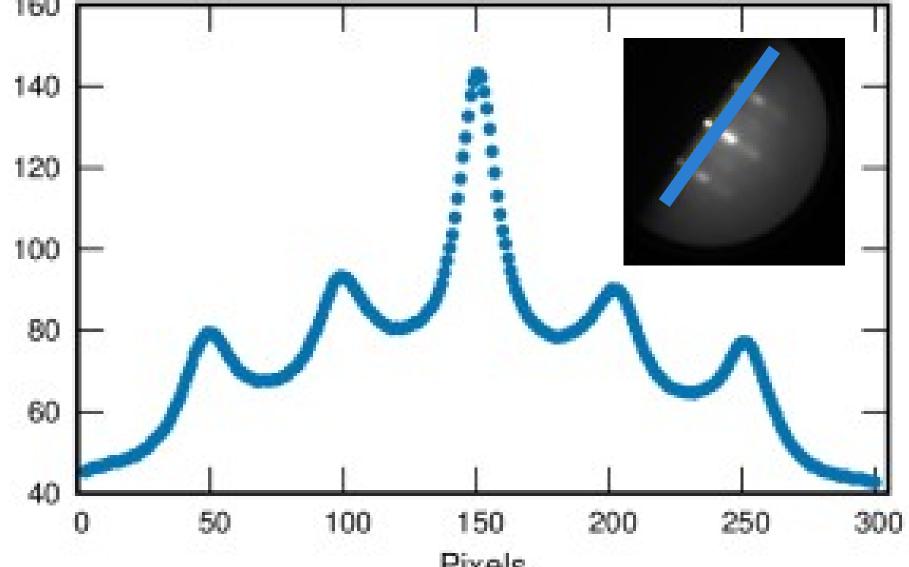
Measuring Success



• Film structure is characterized using synchrotron xray diffraction (XRD) at Argonne National Lab. Above is an XRD pole figure from a disordered sample, confirming a hexagonal structure

 Lattice structures are also determined in-situ using electron diffraction, providing real time feedback about the success of the growth

 Inset below is the electron diffraction pattern from an ordered film, with the graph showing a line profile from the pattern



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via optical absorption and Hall effect, respectively

concentration, which can mask the actual band gap

concentration in the films to obtain more accurate properties of ZnSnN, as a function of cation order